

## Features

- CRM(CQ) Super\_Junction technology
- Much lower Ron\*A performance for On-state efficiency
- Better efficiency due to very low FOM
- Ultra-fast body diode
- Qualified for industrial grade applications according to JEDEC

## Product Summary

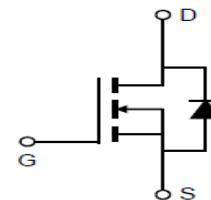
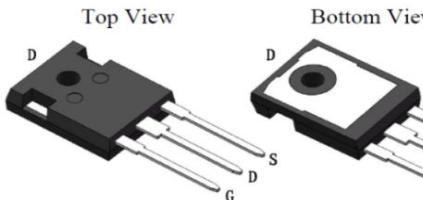
$V_{DS,min}$	650V
$R_{DS(on),typ}$	103mΩ
$I_D$	27A

## Applications

- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

**100% DVDS Tested**

**100% Avalanche Tested**



## Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJQ125N65G2BF	CRJQ125N65G2BF	TO-247	Tube	N/A	N/A	25pcs

## Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	$V_{DS}$	650	V
Continuous drain current <sup>1)</sup> $T_C = 25^\circ C$ $T_C = 100^\circ C$	$I_D$	27 17	A
Pulsed drain current <sup>2)</sup> ( $T_C = 25^\circ C$ , $t_p$ limited by $T_{j,max}$ )	$I_{D,pulse}$	80	A
Avalanche energy, single pulse ( $L=30mH$ )	$E_{AS}$	300	mJ
MOSFET dv/dt ruggedness	dv/dt	50	V/ns
Gate-Source voltage	$V_{GS}$	$\pm 30$	V
Power dissipation ( $T_C = 25^\circ C$ )	$P_{tot}$	210	W
Continuous diode forward current( $T_C = 25^\circ C$ )	$I_S$	27	A
Diode pulse current <sup>2)</sup> ( $T_C = 25^\circ C$ )	$I_{S,pulse}$	80	A
Recovery diode dv/dt <sup>3)</sup>	dv/dt	50	V/ns
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55...+150	°C

1) Limited by  $T_{j,max}$ . Maximum Duty Cycle D = 0.50;

2) Pulse width  $t_p$  limited by  $T_{j,max}$

3) Identical low side and high side switch with identical  $R_g$

**Thermal Resistance**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction – case	R <sub>thJC</sub>	-	0.42	0.59	°C/W	
Thermal resistance, junction – ambient	R <sub>thJA</sub>	-	-	46	°C/W	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	650	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
Gate threshold voltage	V <sub>GS(th)</sub>	3.2	-	4.6	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
Zero gate voltage drain current	I <sub>DSS</sub>	-	-	5	μA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V T <sub>j</sub> =25°C T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	103	125	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =12A, T <sub>j</sub> =25°C T <sub>j</sub> =150°C
Transconductance	g <sub>f</sub>	-	17	-	S	V <sub>DS</sub> =20V, I <sub>D</sub> =12A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	1580	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=100KHz
Output Capacitance	C <sub>oss</sub>	-	88	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	1.2	-		
Gate Total Charge	Q <sub>g</sub>	-	52	-	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =12A
Gate-Source charge	Q <sub>gs</sub>	-	14	-		
Gate-Drain charge	Q <sub>gd</sub>	-	30	-		
Gate plateau voltage	V <sub>plateau</sub>	-	7.6	-	V	V <sub>GS</sub> =10V, I <sub>D</sub> =12A, V <sub>DS</sub> =400V, R <sub>g</sub> =2Ω
Turn-on delay time	t <sub>d(on)</sub>	-	25	-		
Rise time	t <sub>r</sub>	-	50	-		
Turn-off delay time	t <sub>d(off)</sub>	-	65	-		
Fall time	t <sub>f</sub>	-	28	-		
Gate resistance	R <sub>g,int</sub>	-	9	-	Ω	f=1MHz



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CRJQ125N65G2BF

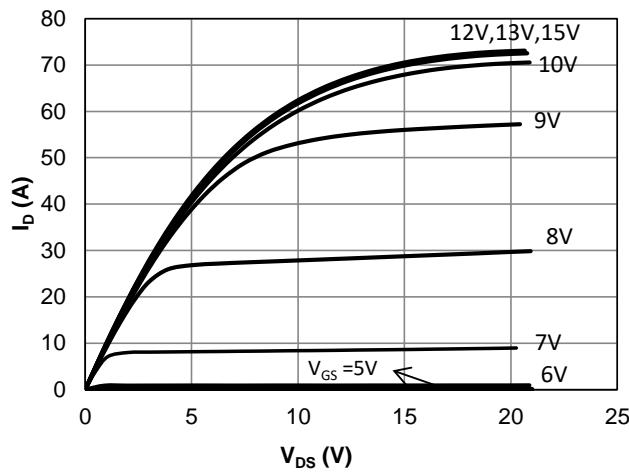
SJMOS N-MOSFET 650V, 103mΩ, 27A

### Body Diode Characteristic

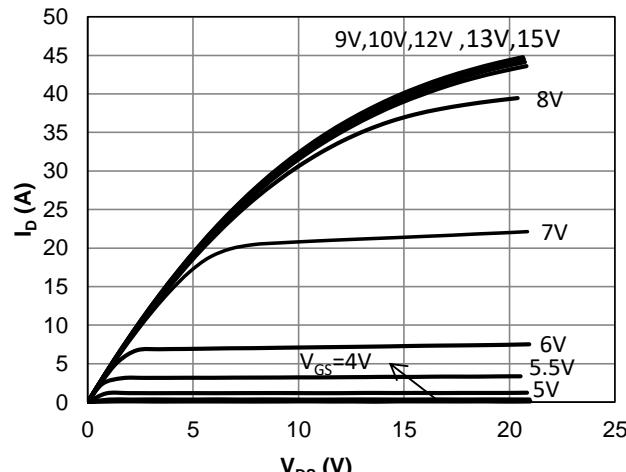
Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	$V_{SD}$	0.7	0.9	1.1	V	$V_{GS}=0V, I_{SD}=12A$
Body Diode Reverse Recovery Time	$t_{rr}$	-	97	-	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$	-	0.4	-	μC	$I_{SD}=12A$ $dI_F/dt=100A/\mu s$ $V_{DS}=400V$
Body Diode Reverse Recovery Peak Current	$I_{rrm}$	-	7.5	-	A	

## Typical Performance Characteristics

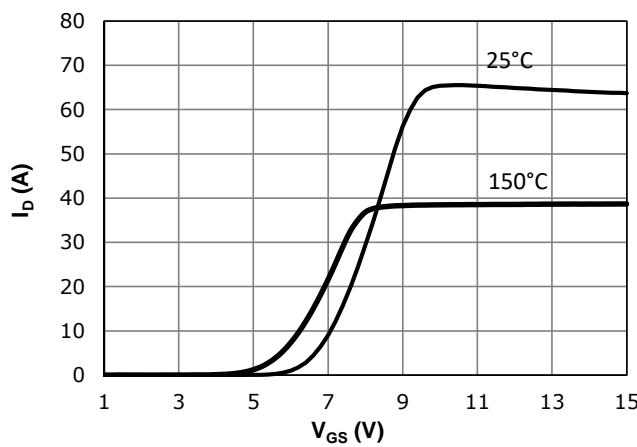
**Fig 1. Output Characteristics ( $T_j=25^\circ\text{C}$ )**



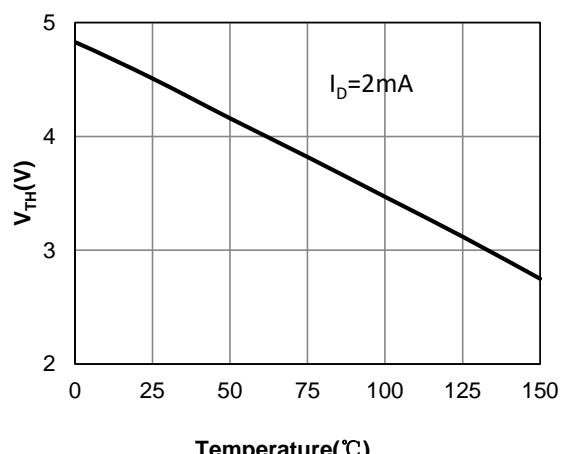
**Fig 2. Output Characteristics ( $T_j=150^\circ\text{C}$ )**



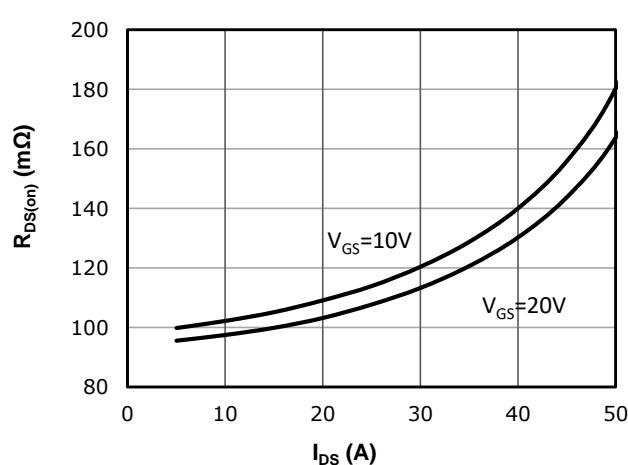
**Fig 3: Transfer Characteristics**



**Fig 4:  $V_{TH}$  vs.  $T_j$  Temperature Characteristics**



**Fig 5:  $R_{DS(on)}$  vs.  $I_{DS}$  Characteristics ( $T_j=25^\circ\text{C}$ )**



**Fig 6:  $R_{DS(on)}$  vs. Temperature**

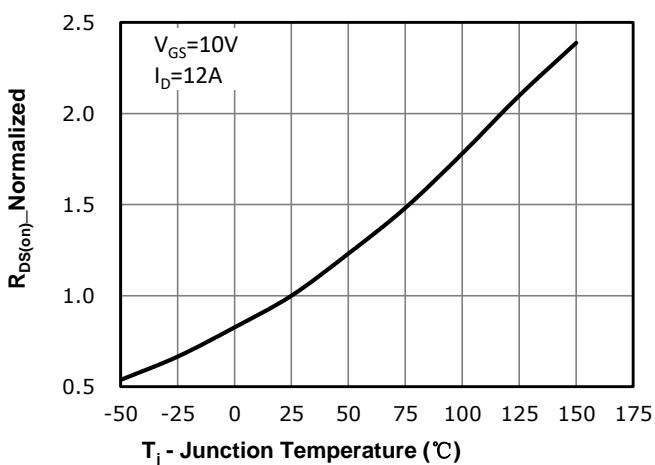


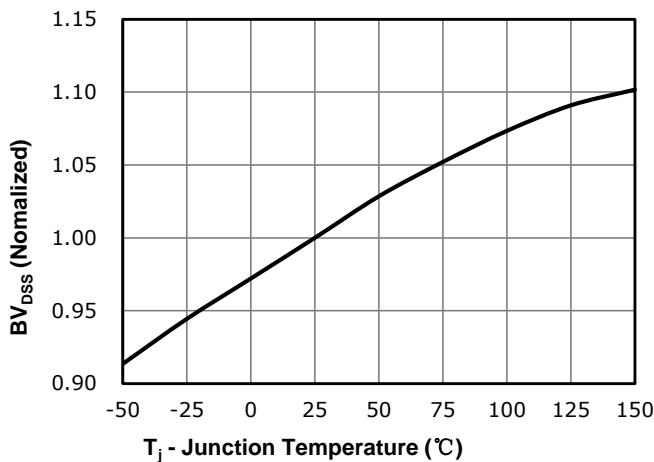
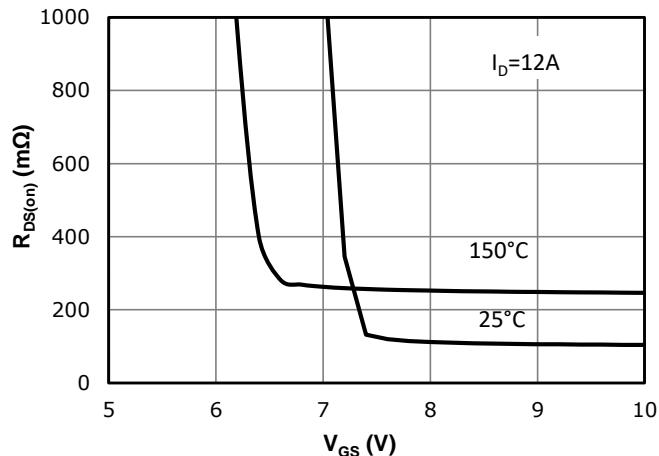
Fig 7:  $BV_{DSS}$  vs. Temperature

 Fig 8:  $R_{DS(on)}$  vs. Gate Voltage


Fig 9: Body-diode Forward Characteristics

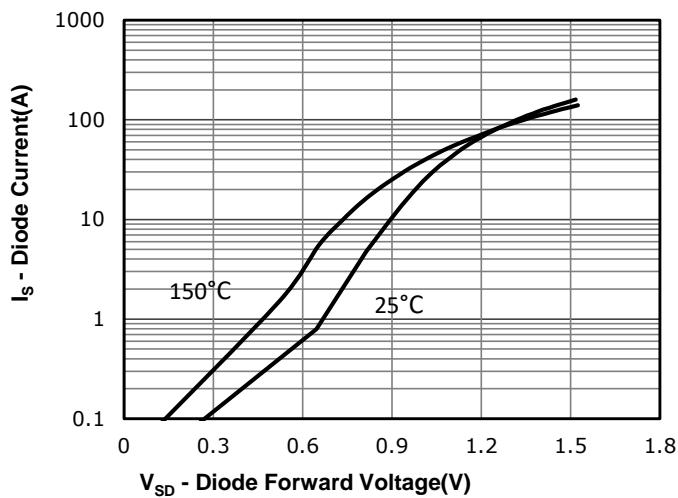


Fig 10: Gate Charge Characteristics

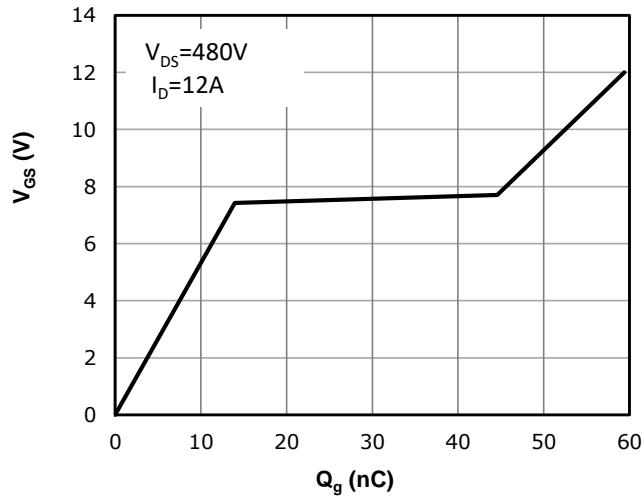


Fig 11: Capacitance Characteristics

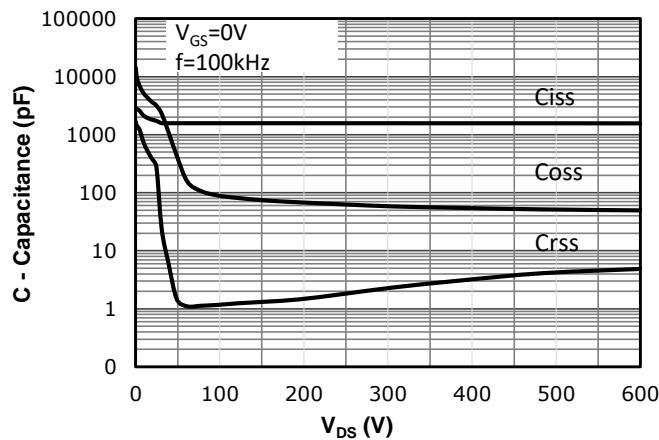


Fig 12: Safe Operating Area

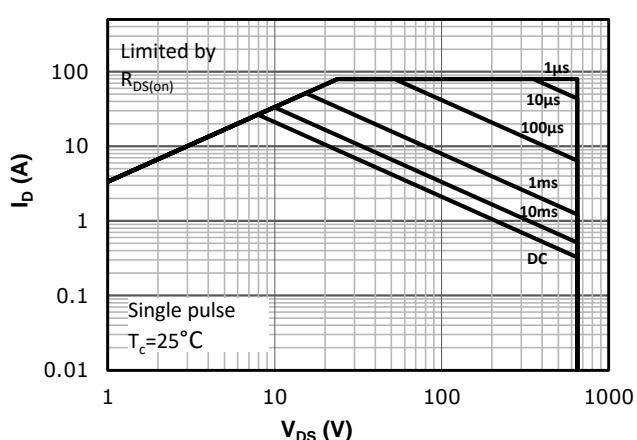
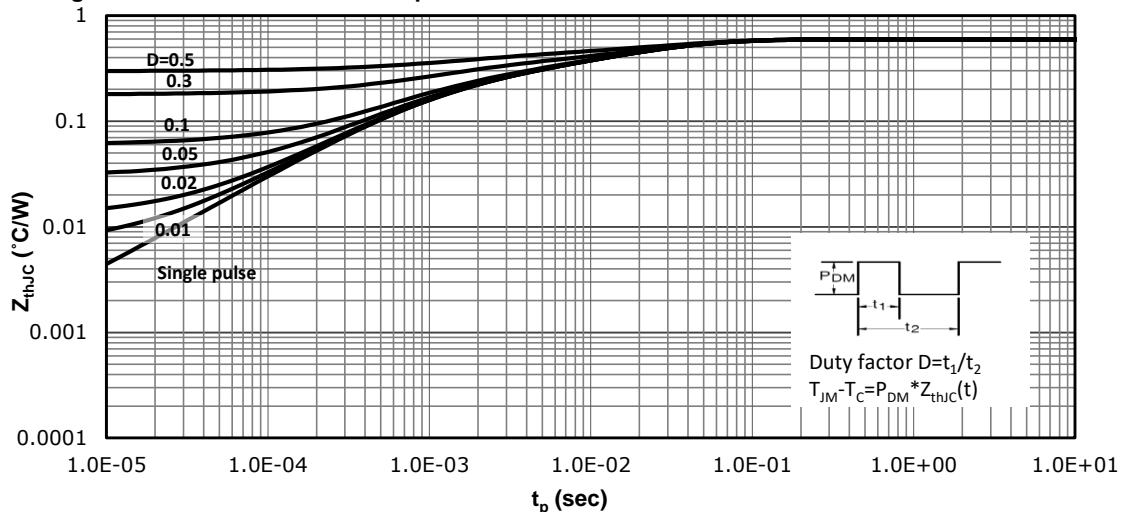
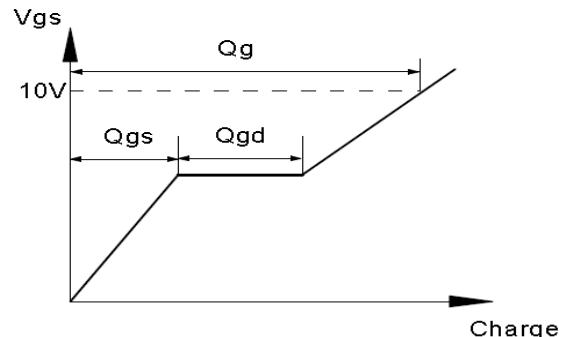
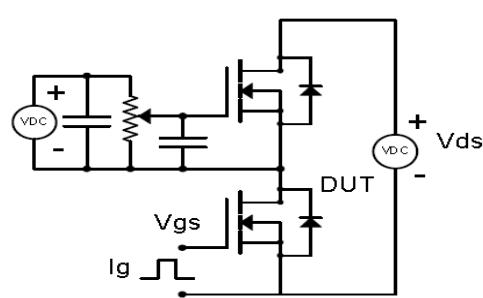


Fig 13: Max. Transient Thermal Impedance

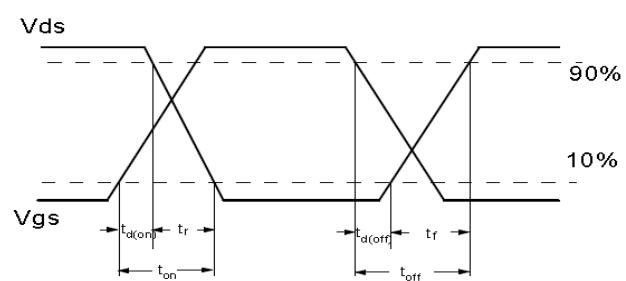
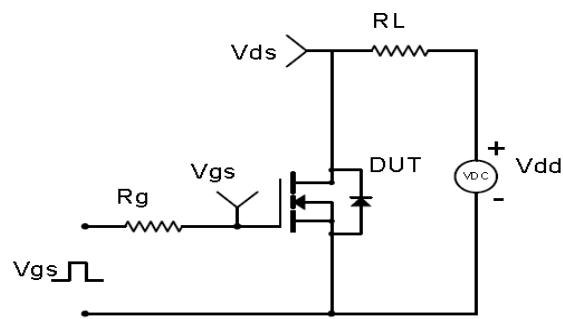


**Test Circuit & Waveform**

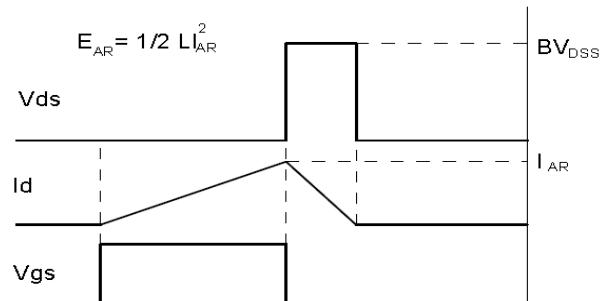
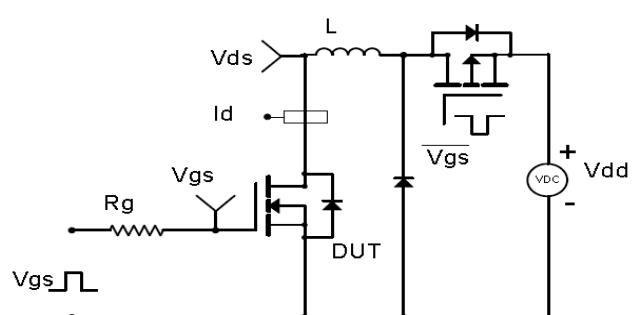
Gate Charge Test Circuit &amp; Waveform



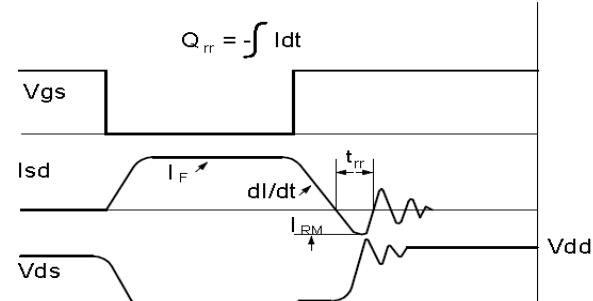
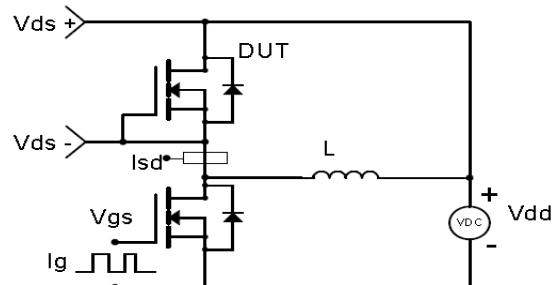
Resistive Switching Test Circuit &amp; Waveforms

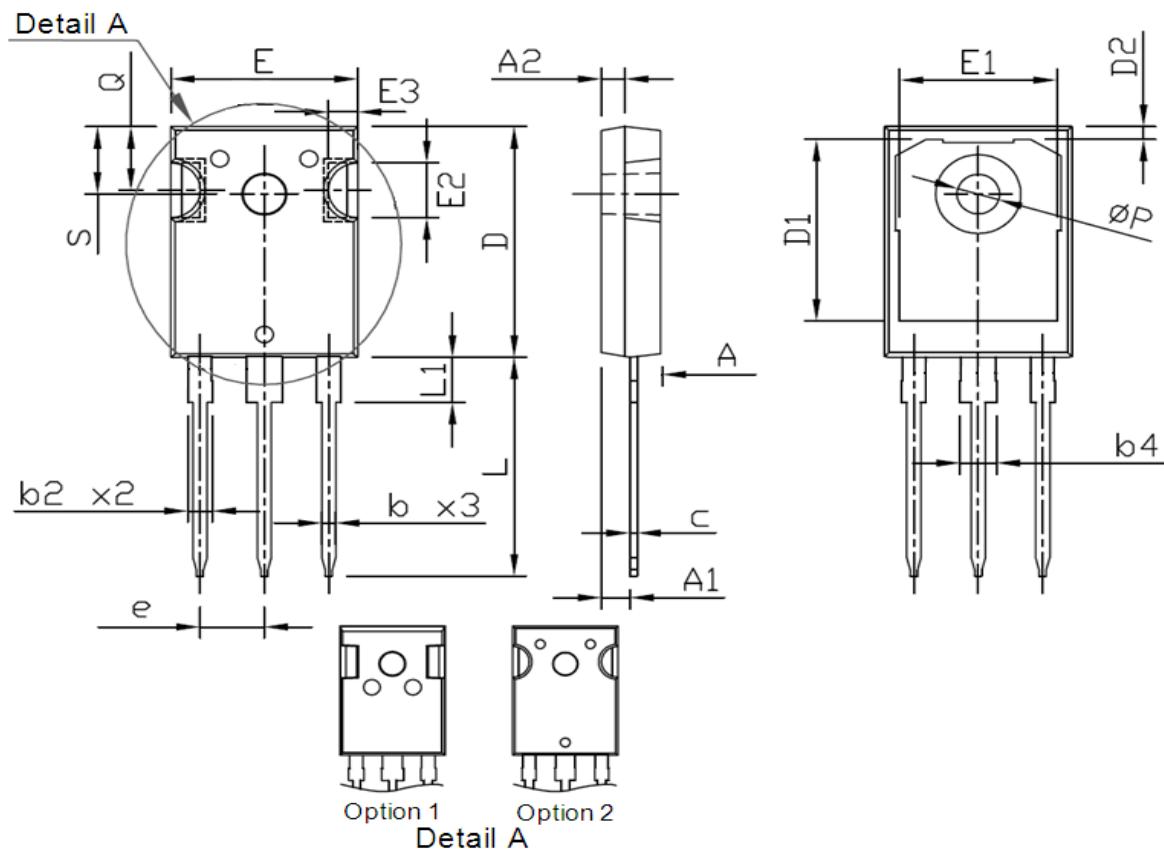


Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms



**Package Outline: TO-247-3L**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.70	5.30	0.185	0.209
A1	2.20	2.60	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	1.04	1.33	0.041	0.052
b2	1.90	2.41	0.075	0.095
b4	2.87	3.43	0.113	0.135
c	0.55	0.70	0.022	0.028
D	20.70	21.30	0.815	0.839
D1	16.25	17.65	0.640	0.695
D2	0.51	1.40	0.020	0.055
e	5.44 BSC.		0.214 BSC.	
E	15.50	16.30	0.610	0.642
E1	13.08	14.16	0.515	0.557
E2	3.80	5.49	0.150	0.216
E3	1.00	2.75	0.039	0.108
L	19.72	20.32	0.776	0.800
L1	3.85	4.50	0.152	0.177
Q	5.25	6.25	0.207	0.246
P	3.50	3.70	0.138	0.146
S	6.04	6.30	0.238	0.248



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SJMOS N-MOSFET 650V, 103mΩ, 27A

## Marking



### NOTE:

NXBBAAAA

N —WB code (Usually omitted)

X —Assembly location code

BB —Fab code

AAAA —Lot code



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SJMOS N-MOSFET 650V, 103mΩ, 27A

## Revision History

Revison	Major changes
1.0	First version
1.1	Update features

## Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.